

TECHNICAL REPORT



Report No.: EMC 1707177

File reference No.: 2017-08-31

Applicant:

Product: Charging Cable

Brand Name: N/A

Model No.: RC02, RC03

Test Standards: EN 55032:2015
EN61000-3-2:2014
EN 55024: 2010+A1:2015
EN 61000-3-3: 2013

Test result: The EMC testing has been performed on the submitted samples and found in compliance with council EMC Directive 2014/30/EU.

Approved By

Terry Tang
Manager

Dated: Aug 31, 2017

Results appearing herein relate only to the sample tested

The technical reports is issued errors and omissions exempt and is subject to withdrawal at

SHENZHEN TIMEWAY TESTING LABORATORIES.

**Room 512-519, 5/F., East Tower, Building 4, Anhua Industrial Zone,
Futian District, Shenzhen, Guangdong China**

Tel (755) 83448688 Fax (755) 83442996 Email: info@timeway-lab.com



Special Statement:

The testing quality ability of our laboratory meet with "Quality Law of People's Republic of China" Clause 19.

The testing quality system of our laboratory meets with ISO/IEC-17025 requirements, which is approved by CNAS. This approval result is accepted by MRA of APLAC.

Our test facility is recognized, certified, or accredited by the following organizations:

CNAS-LAB Code: L2292

The EMC Laboratory has been assessed and in compliance with CNAS-CL01 accreditation criteria for testing Laboratories (identical to ISO/IEC 17025:2005 General Requirements) for the Competence of testing Laboratories.

FCC-Registration No.: 899988

The EMC Laboratory has been registered and fully described in a report filed with the (FCC) Federal Communications commission. The acceptance letter from the FCC is maintained in our files. Registration No.:899988.

IC- Registration No.: IC5205A-01

The EMC Laboratory has been registered and fully described in a report filed with the (IC) Industry Canada. The acceptance letter from the IC is maintained in our files. Registration No.: IC 5205A-01.

VCCI- Registration No.: R-3015 and C-3332

The EMC Laboratory has been registered and fully described in a report filed with the (VCCI) Voluntary Control Council for Interference. The acceptance letter from the VCCI is maintained in our files. Registration IC No.: R-3015 and C-3332

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TABLE OF CONTENT

1.0 General Details	5
1.1 Test Lab Details	5
1.2 Applicant Details	5
1.3 Description of EUT	5
1.4 Submitted Sample(s)	5
1.5 Test Duration	5
1.6 Additional information of EUT	6
1.7 Test Engineer	6
2.0 List of Measurement Equipment	7
2.1 Conducted Emission Test	7
2.2 Radiated Disturbance Test	7
2.3 Harmonic & Flicker Test	7
2.4 ESD Test	7
2.5 RF field Strength Susceptibility	8
2.6 Electrical Fast Transient/Burst (EFT/B) Immunity test	8
2.7 Surge Test	8
2.8 Conducted Immunity Test	8
2.9 Power-frequency Magnetic Field	8
2.10 Voltage Dips/Interruption Immunity Test	9
3.0 Technical Details	10
3.1 Investigations Requested	10
3.2 Test Standards	10
3.3 Performance Criteria	10
3.4 Test standards and Results Summary Tables	11
4.0 Electromagnetic Interference Test results	12
4.1 Power line Conducted Emission Test	12
4.2 Telecommunication ports Conducted Emission Test	15
4.3 Radiated Disturbance Test	18
4.4 Harmonic Current Emission Test	21
4.5 Voltage Fluctuations & Flicker Test	23
5.0 Immunity Test	25
5.1 Electrostatic Discharge	25
5.2 RF field strength susceptibility (80MHz----- 1000MHz)	27
5.3 Electrical Fast Transient/Burst (EFT/B) immunity test	29
5.4 Surge test	31
5.5 Conducted Immunity test	33
5.6 Power-Frequency magnetic field test	35

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5.7 Voltage Dips/Interruptions immunity test..... 37

6.0 Product Labelling 39

6.1 CE Mark label specification 39

6.2 Mark Location: Rear enclosure..... 39

7.0 Photo of testing..... 40

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1.0 General Details

1.1 Test Lab Details

SHENZHEN TIMEWAY TESTING LABORATORIES.

Room 512-519,5/F., East Tower,Building 4, Anhua Industrial Zone, Futian District,Shenzhen,
Guangdong China

Tel(086) 755-83448688 Fax (086) 755-83442996

Test Location

All tests were performed at:

SHENZHEN TIMEWAY TESTING LABORATORIES.

Room 512-519,5/F., East Tower,Building 4, Anhua Industrial Zone, Futian District,Shenzhen,
Guangdong China

Tel(086) 755-83448688 Fax (086) 755-83442996

No tests were sub-contracted.

1.2 Applicant Details

Applicant:

Address:

Telephone:

Fax: --

Manufacturer:

Address:

Telephone:

Fax: --

1.3 Description of EUT

Product: Charging Cable

Brand Name: N/A

Model Number: RC02

Adding Model Number: RC03

Rating: Input: 5V

Remark: ---

1.4 Submitted Sample(s)

1 Sample

1.5 Test Duration

2017-08-23 to 2017-08-31

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Report No.: EMC1707177
Date: 2017-08-31



Page 6 of 43

1.6 Additional information of EUT

	Submitted	Not Available
User Manual	<input checked="" type="checkbox"/>	<input type="checkbox"/>
Part List	<input type="checkbox"/>	<input type="checkbox"/>
Circuit Diagram	<input checked="" type="checkbox"/>	<input type="checkbox"/>
Printed circuit board[PCB] Layout	<input checked="" type="checkbox"/>	<input type="checkbox"/>
Block Diagram	<input type="checkbox"/>	<input type="checkbox"/>

1.7 Test Engineer

The sample(s) tested by

Print Name: Leo Lau Engineer



This test report is not valid without personnel's signatures of SHENZHEN TIMEWAY TESTING LABORATORIES

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2.0 List of Measurement Equipment

2.1 Conducted Emission Test

Name	Model No.	Serial No.	Manufacturer	Calibration Date	Calibration Cycle
EMI Test Receiver	ESH3	860905/006	RS	2017.07.13	1 Year
Spectrum Analyzer	ESA-L1500A	US37451154	HP	2017.07.13	1 Year
PULSE LIMITER	ESH3-Z2	100281	RS	2017.07.13	1 Year
LISN	ESH3-Z5	100294	RS	2017.07.13	1 Year
LISN	ESH3-Z5	100253	RS	2017.07.13	1 Year

2.2 Radiated Disturbance Test

Name	Model No	Serial No.	Manufacturer	Calibration Date	Calibration Cycle
EMI Test Receiver	ESVD	100008	RS	2017.07.13	1 Year
Coaxial Switch	MP59B	M70585	ANRITSU	N/A	N/A
Spectrum Analyzer	8595E	3441A00893	HP	2017.07.13	1 Year
Amplifier	8447D	2727A05017	HP	2017.07.13	1 Year
Bilog Antenna	VULB9163 91	63/340 Schwarbeck		2017.07.13	1 Year

2.3 Harmonic & Flicker Test

Name	Model No.	Serial No.	Manufacturer	Calibration Date	Calibration Cycle
Harmonics Flicker Test System	PACS-1	72305	CI	2016.11.10	1 Year
5K VA AC Power Source	5001iX	56060	CI	2016.11.10	N/A

2.4 ESD Test

Name	Model No.	Serial No.	Manufacturer	Calibration Date	Calibration Cycle
ESD Simulator	DITO	0404-24	EM TEST	2017.07.10	1 Year

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2.5 RF field Strength Susceptibility

Name	Model No.	Serial No.	Manufacturer	Calibration Date	Calibration Cycle
Signal Generator	SMT03	100059	RS	2017.07.13	1 Year
Power Meter	NRVS	---	RS	2017.07.13	1 Year
Voltage Probe	URV5-Z2	100012	RS	2017.07.13	1 Year
Voltage Probe	URV5-Z2	100013	RS	2017.07.13	1 Year
Power Amplifier	150W1000	300999	AR	2017.07.13	1 Year
Power Amplifier	25S1G4AM1	305993	AR	2017.07.13	1 Year
Field Probe	CBL6111C	2576	Holaday	2017.07.13	1 Year
Bilog Antenna	MCDC	---	Chase	2017.07.13	1 Year

2.6 Electrical Fast Transient/Burst (EFT/B) Immunity test

Name	Model No.	Serial No.	Manufacturer	Calibration Date	Calibration Cycle
EFT Generator	UCS 500 M4	0304-42	EM TEST	2017.07.13	1 Year
Power Source	MV2616	0104-14	EM TEST	2017.07.13	1 Year

2.7 Surge Test

Name	Model No.	Serial No.	Manufacturer	Calibration Date	Calibration Cycle
Ultra Compact Simulator	UCS 500 M4	0304-42	EM TEST	2017.07.13	1 Year
Power Source	MV2616	0104-14	EM TEST	2017.07.13	1 Year

2.8 Conducted Immunity Test

Name	Model No.	Serial No.	Manufacturer	Calibration Date	Calibration Cycle
Continuous Wave Simulator	CWS 500C	0407-05	EM TEST	2017.07.13	1 Year

2.9 Power-frequency Magnetic Field

Name	Model No.	Serial No.	Manufacturer	Calibration Date	Calibration Cycle
Continuous Wave Simulator	UCS 500 M4	0304-42	EM TEST	2017.07.13	1 Year
Power Source Network	MV 2616	0104-14	EM TEST	2017.07.13	1 Year
Current Transformer	MC2630	--	EM TEST	2017.07.13	1 Year

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Magnetic Coil	MS100	0304-42	EM TEST	2017.07.13	1 Year
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2.10 Voltage Dips/Interruption Immunity Test

Name	Model No.	Serial No.	Manufacturer	Calibration Date	Calibration Cycle
Ultra Compact Simulator	UCS 500 M4	0304-42	EM TEST	2017.07.13	1 Year
Power Source	MV2616	0104-14	EM TEST	2017.07.13	1 Year

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3.0 Technical Details

3.1 Investigations Requested

Perform Electromagnetic Interference [EMI] & Electromagnetic Susceptibility[EMS] tests for CE Marking

3.2 Test Standards

Test Standards		
EN 55032:2015	Electromagnetic compatibility of multimedia equipment - Emission Requirements	
EN61000-3-2:2014	Electromagnetic compatibility(EMC)- Part 3-2:Limits-Limits for harmonic current emissions(equipment input current $\leq 16A$ per phase)	
EN 61000-3-3:2013	Electromagnetic compatibility (EMC)- Part 3-3:Limits-Limitation of voltage changes, Voltage fluctuations and flicker in public low-voltage supply systems. For equipment with rated current $\leq 16A$ per phase and not subject to conditional connection	
EN 55024:2010+A1:2015	Information technology equipment — Immunity characteristics — Limits and methods of measurement	
	EN 61000-4-2:2009	Electrostatic discharge
	EN 61000-4-3:2006	RF field strength susceptibility
	EN 61000-4-4:2012	Electrical Fast transients
	EN 61000-4-5:2014	Surge
	EN 61000-4-6:2009	Conducted susceptibility
	EN 61000-4-8:2010	Power-frequency Magnetic Field
	EN 61000-4-11:2004	Dips/Voltage Interruption Variation

3.3 Performance Criteria

Criterion	Description
A	No change in operational mode or degradation of performance outside of specification and no change in stored parameters.
B	Degradation of performance allowed during the test the EUT returning to intended operation after the test.
C	Loss of function allowed during the test, provided that function is self recoverable or can be recovered by operation of controls.

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3.4 Test standards and Results Summary Tables

Test Condition	Test Requirement	Test Method	Test Result
EMISSION Results Summary			
Conducted Emission on AC Mains, 150KHz to 30MHz	EN 55032:2015	EN 55032:2015	N/A
Conducted Emission on at telecommunication ports, 150KHz to 30MHz	EN 55032:2015	EN 55032:2015	N/A
Radiated Emissions, 30MHz to 1GHz	EN 55032:2015	EN 55032:2015	Pass
Harmonic Emissions on AC supply	EN61000-3-2:2014	EN61000-3-2:2014	N/A
Voltage fluctuations on AC supply	EN 61000-3-3: 2013	EN 61000-3-3: 2013	N/A
IMMUNITY Results Summary			
Electrostatic Discharge	EN 55024: 2010+A1:2015	EN 61000-4-2: 2009	Pass
Electrical Fast transients /Burst Immunity	EN 55024: 2010+A1:2015	EN 61000-4-4: 2012	N/A
RF field strength susceptibility	EN 55024: 2010+A1:2015	EN 61000-4-3: 2006	Pass
Surge	EN 55024: 2010+A1:2015	EN 61000-4-5: 2014	N/A
Conducted susceptibility	EN 55024: 2010+A1:2015	EN 61000-4-6: 2009	N/A
Power-frequency Magnetic Field	EN 55024: 2010+A1:2015	EN61000-4-8: 2010	N/A
Dips/Voltage Interruption Variation	EN 55024: 2010+A1:2015	EN 61000-4-11: 2004	N/A

Note: N/A-Not applicable

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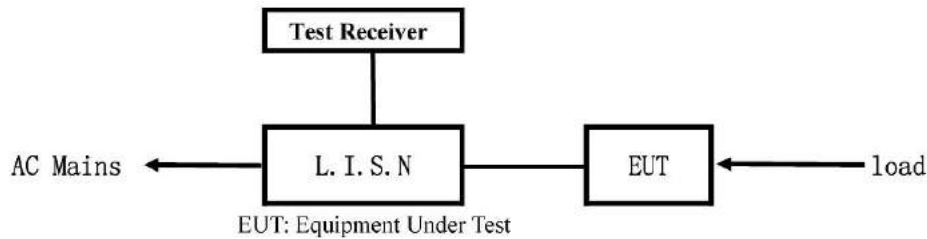
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4.0 Electromagnetic Interference Test results

4.1 Power line Conducted Emission Test

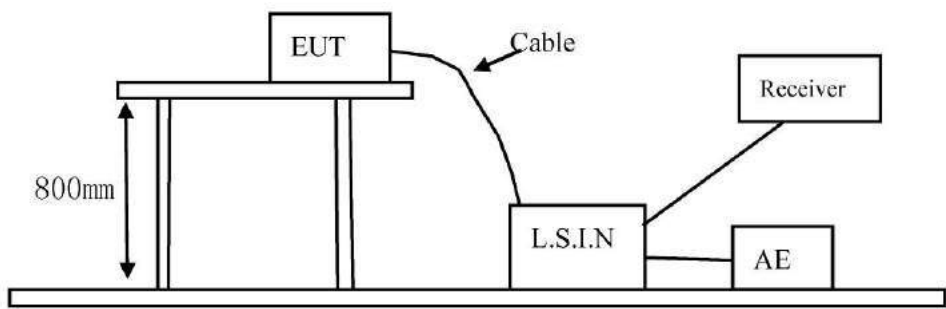
4.1.1 Schematics of the test



4.1.2 Test Method:

The test was performed in accordance with EN 55032:2015

Block diagram of Test setup



4.1.3 Power line conducted Emission Limit

Frequency(MHz)	Limits dB(μ V)			
	Class A Equipment		Class B Equipment	
	Quasi-peak Level	Average Level	Quasi-peak Level	Average Level
0.15 ~ 0.50	79.0	66.0	66.0~56.0*	56.0~46.0*
0.50 ~ 5.00	73.0	60.0	56.0	46.0
5.00 ~ 30.00	73.0	60.0	60.0	50.0

- Notes:
- *decreasing linearly with logarithm of frequency.
 - The lower limit shall apply at the transition frequencies

4.1.4 Test Results

Limits for Conducted Emission test, Please refer to limit line (Quasi-peak)and Average in the following diagram labelled as (QP)&AV

Remark:

Calculated measurement uncertainty=3.6dB

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A: Conducted Emission on Live Terminal (150kHz to 30MHz)

EUT Operating Environment

Temperature: 26°C Humidity: 65%RH Atmospheric Pressure: 101 KPa

EUT set Condition: Charging

Equipment Level: Class B

Results:N/A

Please refer to following diagram for individual

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B: Conducted Emission on Neutral Terminal (150kHz to 30MHz)

EUT Operating Environment

Temperature: 26°C Humidity: 65%RH Atmospheric Pressure: 101 KPa

EUT set Condition: Charging

Equipment Level: Class B

Results: N/A

Please refer to following diagram for individual

The report refers only to the sample tested and does not apply to the bulk.

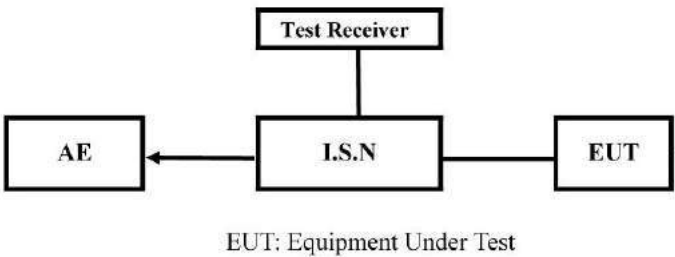
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4.2 Telecommunication ports Conducted Emission Test

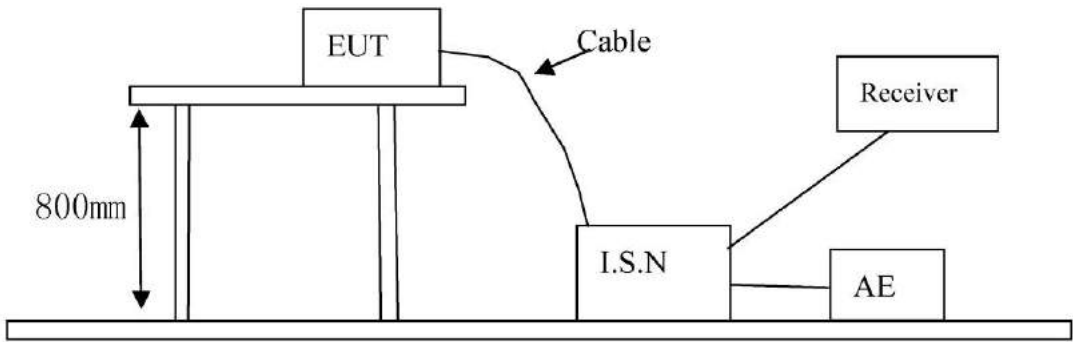
4.2.1 Schematics of the test



4.2.2 Test Method:

The test was performed in accordance with EN 55032:2015

Block diagram of Test setup



4.2.3 Telecommunication ports conducted Emission Limit

Frequency(MHz)	Class A Limits				Class B Limits			
	Quasi-peak Level		Average Level		Quasi-peak Level		Average Level	
	Voltage dB(uV)	Current dB(uA)	Voltage dB(uV)	Current dB(uA)	Voltage dB(uV)	Current dB(uA)	Voltage dB(uV)	Current dB(uA)
0.15 ~ 0.50	97 to 87	53 to 43	84 to 74	40 to 30	84 to 74	40 to 30	74 to 64	30 to 20
0.50 ~ 30.00	87	43	74	30	74	30	64	20

- Notes: 1. *decreasing linearly with logarithm of frequency.
2. The tighter limit shall apply at the transition frequencies

4.2.4 Test Results

Limits for Conducted Emission test, Please refer to limit line (Quasi-peak)and Average in the following diagram labelled as (QP)&AV

Remark:

Calculated measurement uncertainty=1.9dB

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Report No.: EMC1707177
Date: 2017-08-31



Page 16 of 43

A: Conducted Emission on Telecommunication port (150kHz to 30MHz)

EUT Operating Environment

Temperature: 25°C Humidity: 75 %RH Atmospheric Pressure: 101 KPa

EUT set Condition: Normal operation mode

Equipment Level: Class B

Results: N/A

Please refer to following diagram for individual

Frequency (MHz)	Port	Reading(dBμV)		Limit(dBμV)	
		Quasi-peak	Average	Quasi-peak	Average
--	LAN	--	--	--	--
--	LAN	--	--	--	--

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Report No.: EMC1707177
Date: 2017-08-31



Page 17 of 43

B: Conducted Emission on Telecommunication port (150kHz to 30MHz)

EUT Operating Environment

Temperature: 25°C Humidity: 75 %RH Atmospheric Pressure: 101 KPa

EUT set Condition: Normal operation mode

Equipment Level: ClassB

Results: N/A

Please refer to following diagram for individual

Frequency (MHz)	Port	Reading(dBμA)		Limit(dBμA)	
		Quasi-peak	Average	Quasi-peak	Average
--	LAN	--	--	--	--

The report refers only to the sample tested and does not apply to the bulk.

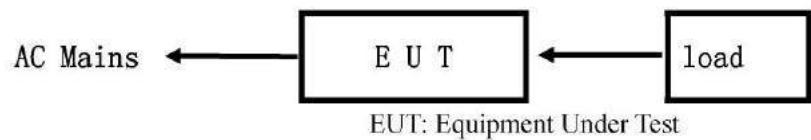
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4.3 Radiated Disturbance Test

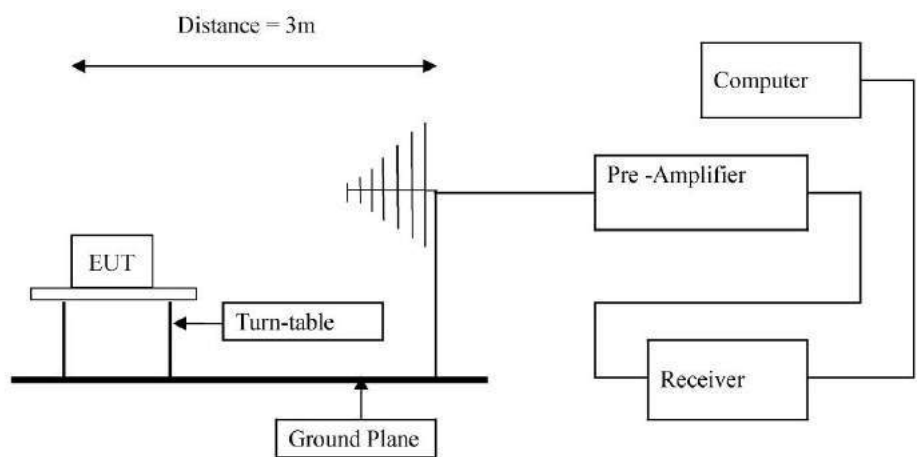
4.3.1 Schematics of the test



4.3.2 Test Method:

The test was performed in accordance with EN 55032:2015

Block diagram of Test setup



4.3.3 Radiated Disturbance Test Limit

Frequency Range (MHz)	Quasi-Peak limits (dB μ V/m)	
	Class A Limits	Class B Limits
30-230	50.00	40.00
230-1000	57.00	47.00

Note: The lower limit shall apply at the transition frequencies

4.3.4 Test result

Limits for Radiated Disturbance test, Please refer to limit line (Quasi-peak) in the following diagram labelled as (QP)

Remark:

Calculated measurement uncertainty=4.7dB

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A: Radiated Disturbance (30MHz----1000MHz)

EUT Operating Environment

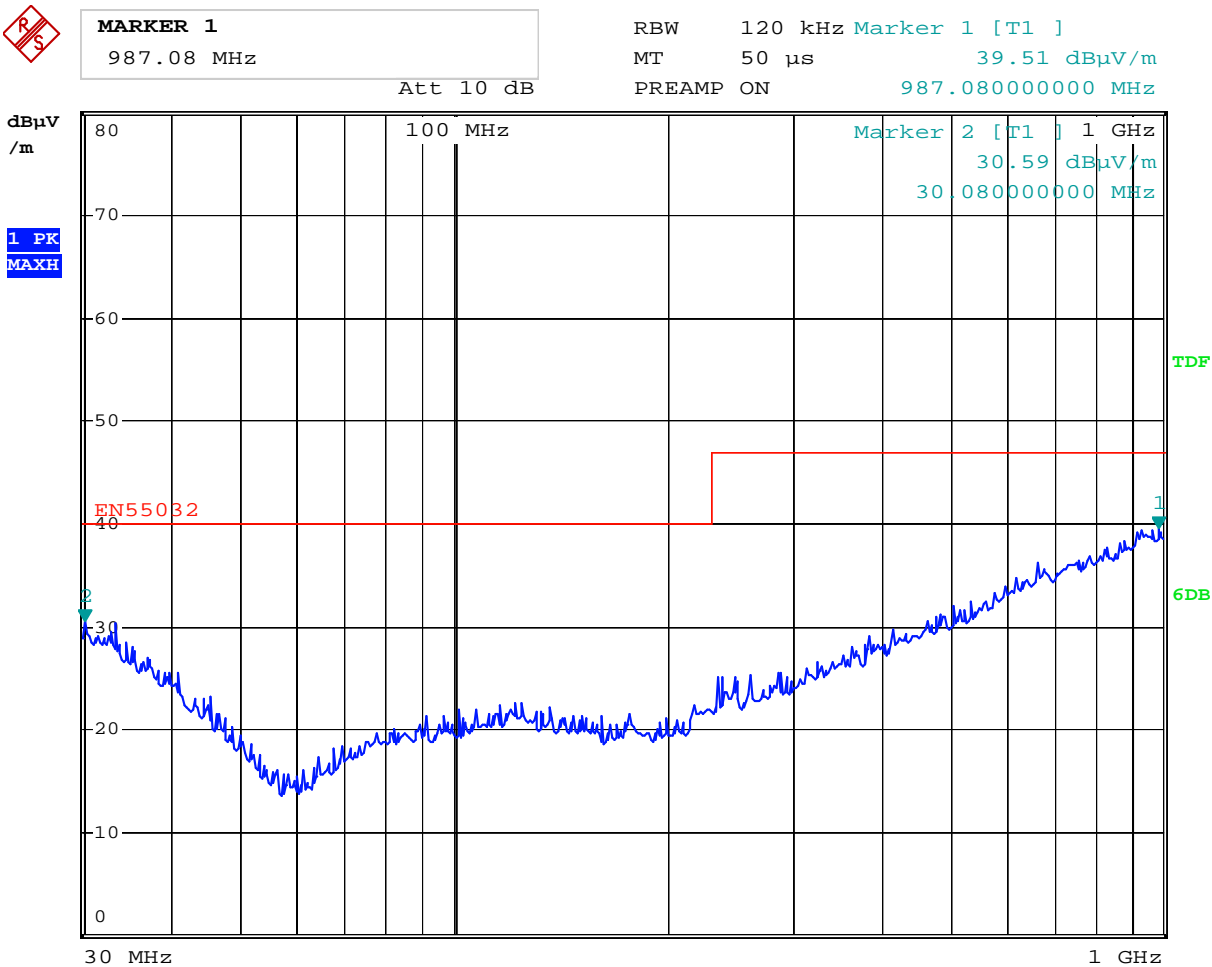
Temperature: 25℃ Humidity: 55%RH Atmospheric Pressure: 101 KPa

EUT set Condition: Charging

Equipment Level: Class B

Results: Pass

Please refer to following diagram for individual



Date: 29.Aug.2017 15:33:05

Frequency (MHz)	Level@3m (dBμV/m)	Antenna Polarity	Limit@3m (dBμV/m)
987.080	39.51	H	47.00
30.080	30.59	H	40.00

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B: Radiated Disturbance (30MHz----1000MHz)

EUT Operating Environment

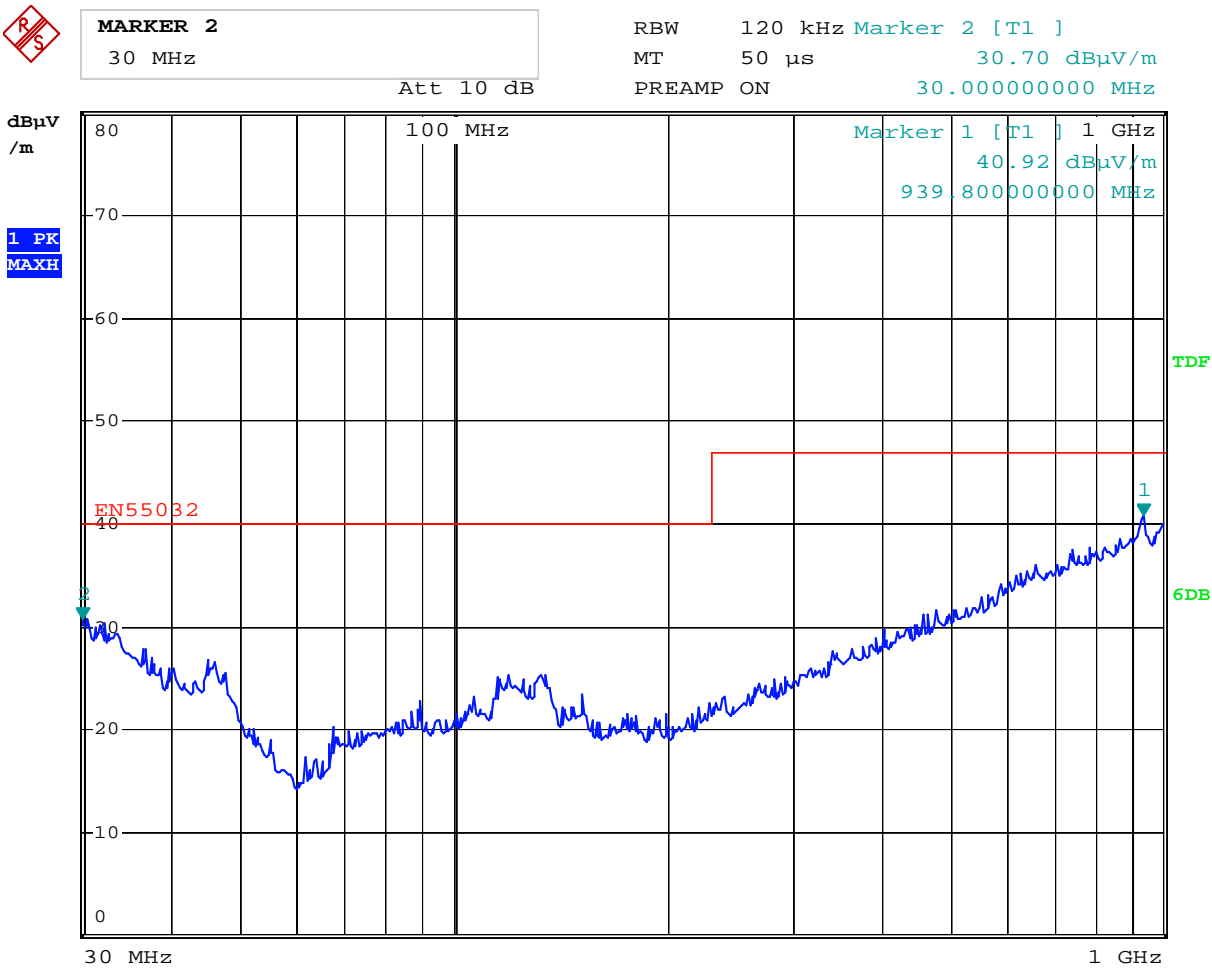
Temperature: 25℃ Humidity: 55%RH Atmospheric Pressure: 101 KPa

EUT set Condition: Charging

Equipment Level: Class B

Results: Pass

Please refer to following diagram for individual



Date: 29.Aug.2017 15:38:20

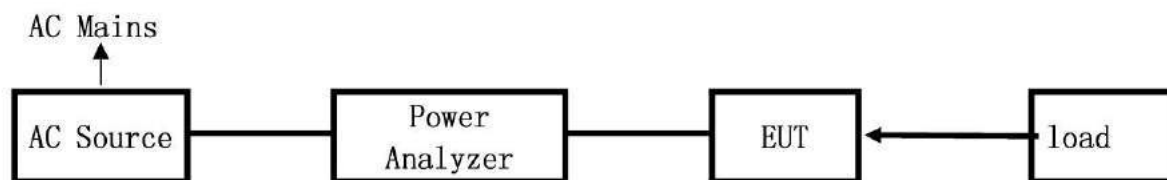
Frequency (MHz)	Level@3m (dBμV/m)	Antenna Polarity	Limit@3m (dBμV/m)
30.000	30.70	V	40.00
939.800	40.92	V	47.00

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4.4 Harmonic Current Emission Test

4.4.1 Schematic of the test



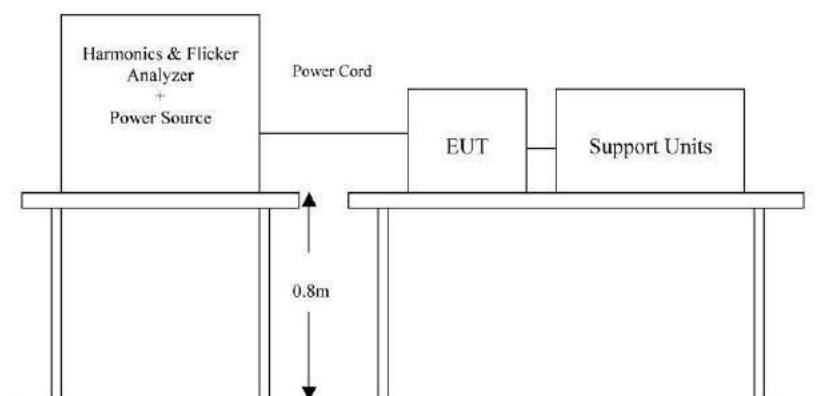
EUT: Equipment Under Test

4.4.2 Test Method:

The test was performed in accordance with EN61000-3-2:2014

*: The Level of the product is : CLASS D

Block diagram of Test setup



4.4.3 Limits of Harmonic Current Emission For Class A

Harmonic order n	Maximum permissible harmonic current A
Odd harmonics	
3	2,30
5	1,14
7	0,77
9	0,40
11	0,33
13	0,21
$15 \leq n \leq 39$	$0,15 \frac{15}{n}$
Even harmonics	
2	1,08
4	0,43
6	0,30
$8 \leq n \leq 40$	$0,23 \frac{8}{n}$

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4.4.4 Test Results

Please refer to the following pages

Harmonic Current Emission Test

EUT Operating Environment

Temperature: 25°C Humidity: 53%RH Atmospheric Pressure: 101 Kpa

EUT set Condition:

Results: N/A

Please refer to following diagram for individual

Harmonic results as a% of the limits

No	(Test result/Limit)%	No	(Test result/Limit)%	No	(Test result/Limit)%	No	(Test result/Limit)%
1		11		21		31	
2		12		22		32	
3		13		23		33	
4		14		24		34	
5		15		25		35	
6		16		26		36	
7		17		27		37	
8		18		28		38	
9		19		29		39	
10		20		30		40	

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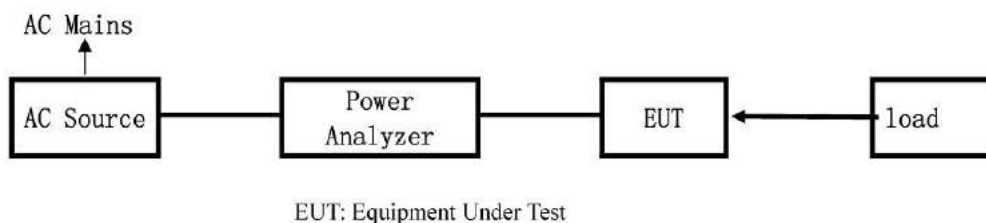
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4.5 Voltage Fluctuations & Flicker Test

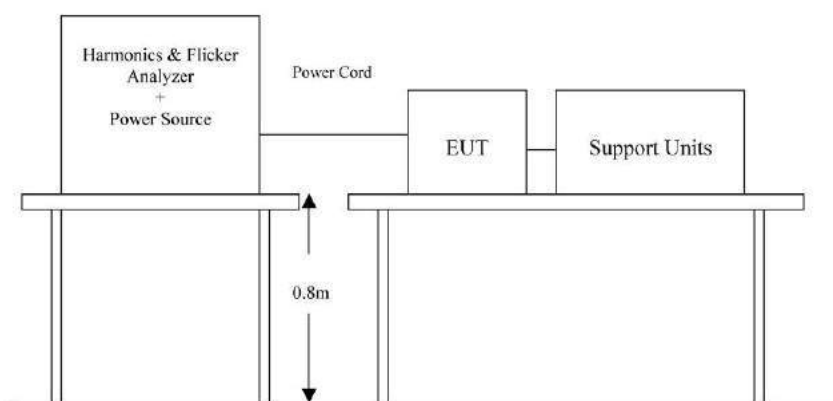
4.5.1 Schematic of the test



4.5.2 Test Method:

The test was performed in accordance with EN 61000-3-3:2013

Block diagram of Test setup



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4.5.3 Test Results

Result: N/A

Please refer to following diagram for individual

Maximum Occurring Levels:

Ut: 230.1 (EUT Test RMS Voltage)

Pst:	Limit=	1.0	(The Highest short Term Flicker Value)
Plt:	Limit=	0.65	(The Highest Long Term Flicker Value)
dt(%):	Limit=	3.3%	(The Highest instantaneous Voltage Change (10ms))
dc(%):	Limit=	3.3%	(The highest Relative steady state voltage change (1sec))
dmax:	Limit=	4%	(The highest Max Relative voltage change)
Tdt:	Limit=	500ms	(The Max Time(in milli-sec) that dt exceeds 3%)

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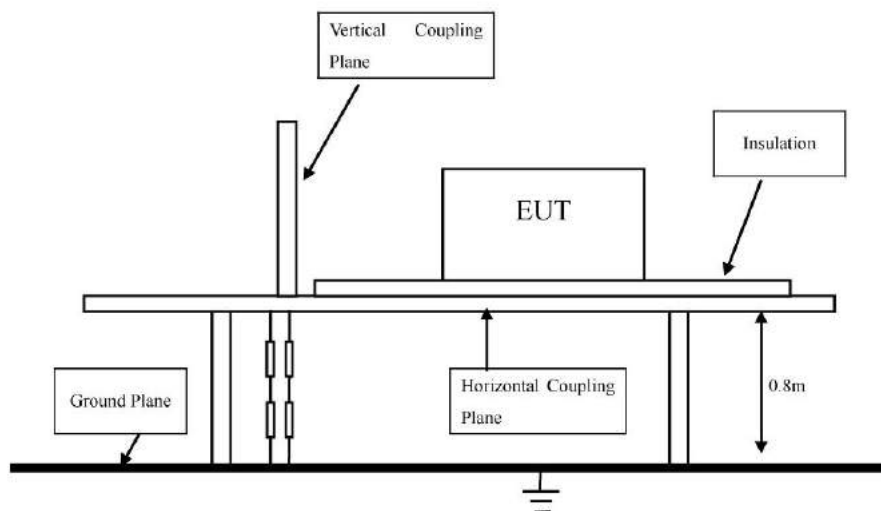
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5.0 Immunity Test

5.1 Electrostatic Discharge

5.1.1 Schematic of the test



5.1.2 Test method

The test was performed in accordance with EN 61000-4-2: 2009

5.1.3 Test severity

$\pm 4\text{Kv}$ for direct & in-direct Contact Discharge

$\pm 8\text{Kv}$ for air Discharge

Performance Criterion Require: **B** (Please see following table)

5.1.4 Susceptibility performance Criteria and Severity level

Criterion	Description
A	No change in operational mode or degradation of performance outside of specification and no change in stored parameters.
B	Degradation of performance allowed during the test the EUT returning to intended operation after the test.
C	Loss of function allowed during the test, provided that function is self recoverable or can be recovered by operation of controls.

Severity Level

Level	Test Voltage Direct & in-direct contact Discharge (Kv)	Test Voltage Air discharge(Kv)
1	$\pm 2\text{Kv}$	$\pm 2\text{Kv}$
2	$\pm 4\text{Kv}$	$\pm 4\text{Kv}$
3	$\pm 6\text{Kv}$	$\pm 8\text{Kv}$
4	$\pm 8\text{Kv}$	$\pm 15\text{Kv}$

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5.1.5 Test Result

EUT Operating Environment

Temperature: 25°C Humidity: 53%RH Atmospheric Pressure: 101 Kpa

Please refer to the following table for individual results.

Location	Discharge Method	Test Voltage	Results
HCP	In-Direct	$\pm 2Kv, \pm 4Kv$	Pass
VCP	In-Direct	$\pm 2Kv, \pm 4Kv$	Pass
Shell (metal)	Contact Discharge	$\pm 2Kv, \pm 4Kv$	Pass
Screw	Contact Discharge	$\pm 2Kv, \pm 4Kv$	Pass
Function key	Air Discharge	$\pm 2kV, \pm 4kV, \pm 8kV$	Pass
Gap	Air Discharge	$\pm 2kV, \pm 4kV, \pm 8kV$	Pass

Remark: Calculated measurement uncertainty= 0.2kV

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5.2 RF field strength susceptibility (80MHz----- 1000MHz)

5.2.1 Schematics of the test



5.2.2 Test Method:

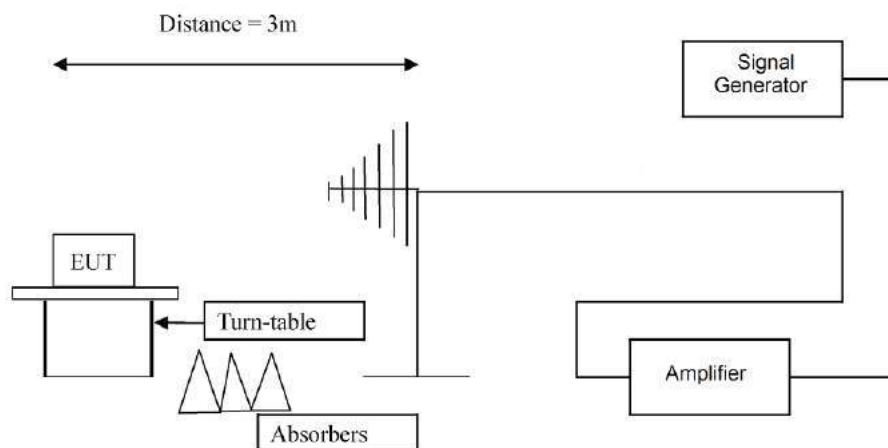
The test was performed in accordance with EN 61000-4-3:2006

Severity: Level 2 (3V/m)

Modulation: 80% AM

Performance Criterion Require: A (Please see following table)

Block diagram of Test setup



5.2.3 Susceptibility performance Criteria and severity Level

Susceptibility performance Criteria

Criterion	Description
A	No change in operational mode or degradation of performance outside of specification and no change in stored parameters.
B	Degradation of performance allowed during the test the EUT returning to intended operation after the test.
C	Loss of function allowed during the test, provided that function is self recoverable or can be recovered by operation of controls.

Severity Level

Level	Field Strength (V/m)
1	1
2	3
3	10

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5.2.4 Test Result:

EUT Operating Environment

Temperature: 25°C Humidity: 75%RH Atmospheric Pressure: 101 KPa

Please refer to the following table for individual results.

Frequency (MHz)	Face	Polarity	Level (V/m)	Dwell Time(s)	Sweep Rate (%)	Results
80-1000	0°	Horizontal	3	1	1	Pass
80-1000	90°	Horizontal	3	1	1	Pass
80-1000	180°	Horizontal	3	1	1	Pass
80-1000	270°	Horizontal	3	1	1	Pass
80-1000	0°	Vertical	3	1	1	Pass
80-1000	90°	Vertical	3	1	1	Pass
80-1000	180°	Vertical	3	1	1	Pass
80-1000	270°	Vertical	3	1	1	Pass

Remark: Calculated measurement uncertainty= 80MHz to 1000MHz (+3.7/ -1.3) V/m

The report refers only to the sample tested and does not apply to the bulk.

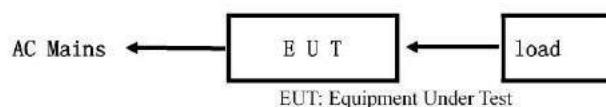
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5.3 Electrical Fast Transient/Burst (EFT/B) immunity test

5.3.1 Schematics of the test



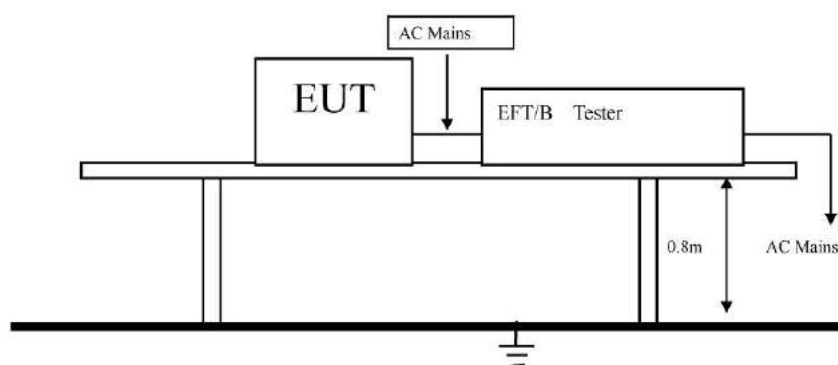
5.3.2 Test Method

The test was performed in accordance with EN 61000-4-4:2012

Severity: Level 2 (1kV)

Performance Criterion Require: **B** (Please see following table)

Block diagram of Test setup



5.3.3 Susceptibility performance Criteria and Severity Level

Criterion	Description
A	No change in operational mode or degradation of performance outside of specification and no change in stored parameters.
B	Degradation of performance allowed during the test the EUT returning to intended operation after the test.
C	Loss of function allowed during the test, provided that function is self recoverable or can be recovered by operation of controls.

Severity Level

Open Circuit output Test Voltage $\pm 10\%$		
Level	On power Supply Lines	On I/O (Input/output) Signal data and control lines
1	0.5kV	0.5kV
2	1kV	1kV
3	2kV	2kV
4	4kV	4kV
X	Special	Special

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5.3.4 Test Results

EUT Operating Environment

Temperature: 25°C Humidity: 75%RH Atmospheric Pressure: 101 KPa

Please refer to following page.

Inject location: AC mains

Inject Line	Voltage kV	Inject Times (s)	Method	Results
L	± 1	120	Direct	Pass
N	± 1	120	Direct	Pass
L-N	± 1	120	Direct	Pass

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5.4 Surge test

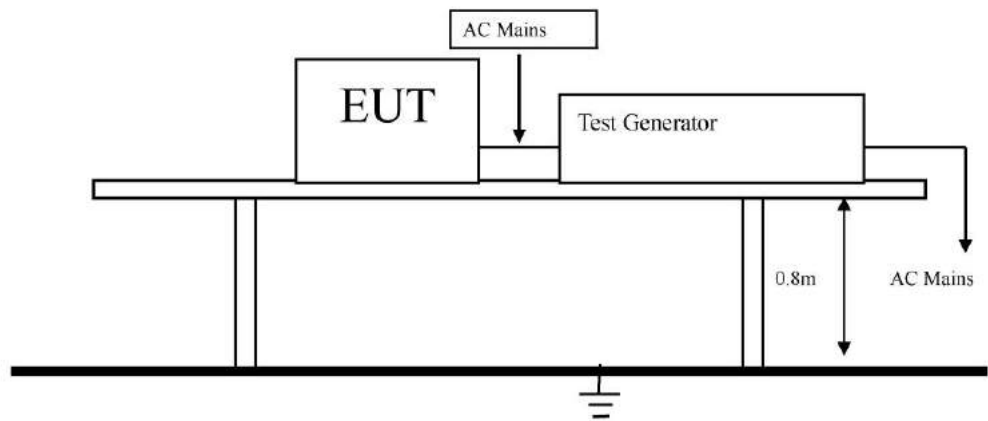
5.4.1 Schematics of the test



5.4.2 Test Method:

The test was performed in accordance with EN 61000-4-5:2014
Severity: Level 2 (Line to Neutral at 1kV)
Performance Criterion Require: B (Please see following table)

Block diagram of Test setup



5.4.3 Susceptibility performance Criteria and Severity Level

Susceptibility performance Criteria

Criterion	Description
A	No change in operational mode or degradation of performance outside of specification and no change in stored parameters.
B	Degradation of performance allowed during the test the EUT returning to intended operation after the test.
C	Loss of function allowed during the test, provided that function is self recoverable or can be recovered by operation of controls.

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Severity Level

Severity Level	Open-Circuit Test Voltage kV
1	0.5
2	1.0
3	2.0
4	4.0
*	Special

5.4.4 Test Results

EUT Operating Environment

Temperature: 25°C Humidity: 75%RH Atmospheric Pressure: 101 KPa

Please refer to following page.

Test location:

Location	Polarity	Phase Angle	No of Pulse	Pulse Voltage(kV)	Results
L-N	±	0	5	1.0	Pass
	±	90	5	1.0	Pass
	±	180	5	1.0	Pass
	±	270	5	1.0	Pass

The report refers only to the sample tested and does not apply to the bulk.

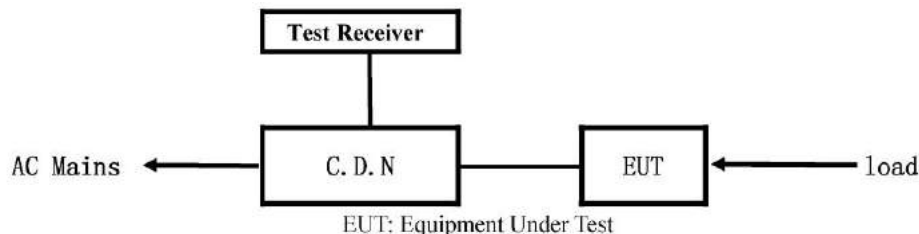
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5.5 Conducted Immunity test

5.5.1 Schematics of the test



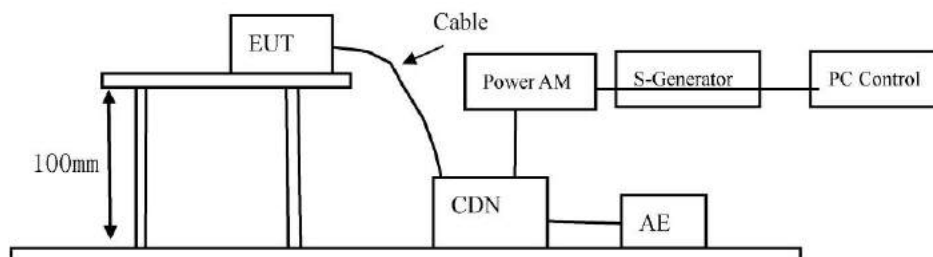
5.5.2 Test Method

The test was performed in accordance with EN 61000-4-6:2009

Severity: Level 2 (3 V rms), 0.15MHz—80MHz

Performance Criterion Require: A (Please see following table)

Block diagram of Test setup



5.5.3 Susceptibility performance Criteria and Severity Level

Susceptibility performance Criteria

Criterion	Description
A	No change in operational mode or degradation of performance outside of specification and no change in stored parameters.
B	Degradation of performance allowed during the test the EUT returning to intended operation after the test.
C	Loss of function allowed during the test, provided that function is self recoverable or can be recovered by operation of controls.

Severity Level

Severity Level	Voltage Level (e.m.f) V
1	1
2	3
3	10
*	Special

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5.5.4 Test Results:

EUT Operating Environment

Temperature: 25°C Humidity: 75%RH Atmospheric Pressure: 101 KPa

Please refer to the following page

Frequency Range (MHz)	Injected Position	Strength	Criterion	Observation	Result
0.15 - 20	AC Line	3V (rms) Unmodulated	A	A	Pass
20 - 80	AC Line	3V (rms) Unmodulated	A	A	Pass

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5.6 Power-Frequency magnetic field test

5.6.1 Schematics of the test



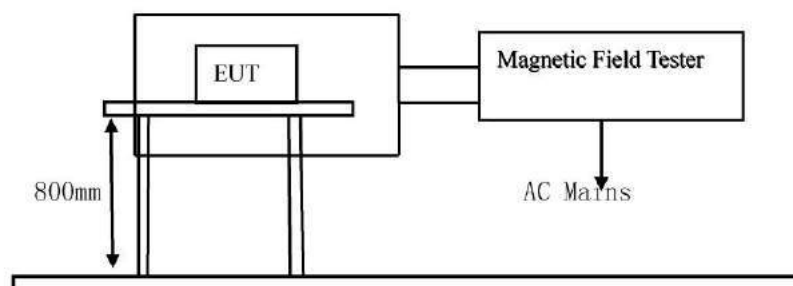
5.6.2 Test Method

The test was performed in accordance with EN 61000-4-8:2010

Severity: Level 1 (1A/m),

Performance Criterion Require: A (Please see following table)

Block diagram of Test setup



5.6.3 Susceptibility performance Criteria and Severity Level

Susceptibility performance Criteria

Criterion	Description
A	No change in operational mode or degradation of performance outside of specification and no change in stored parameters.
B	Degradation of performance allowed during the test the EUT returning to intended operation after the test.
C	Loss of function allowed during the test, provided that function is self recoverable or can be recovered by operation of controls.

Severity Level

Severity Level	Magnetic Field Strength A/m
1	1
2	3
3	10
4	30
5	100
*	Special

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5.6.4 Test Results:

EUT Operating Environment

Temperature: 25°C Humidity: 75%RH Atmospheric Pressure: 101 KPa

Please refer to the following page

Test Level	Testing Duration	Coil Orientation	Criterion	Result
1A/m	5 Mins	X	A	N/A
1A/m	5 Mins	Y	A	N/A
1A/m	5 Mins	Z	A	N/A

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5.7 Voltage Dips/Interruptions immunity test

5.7.1 Schematics of the test

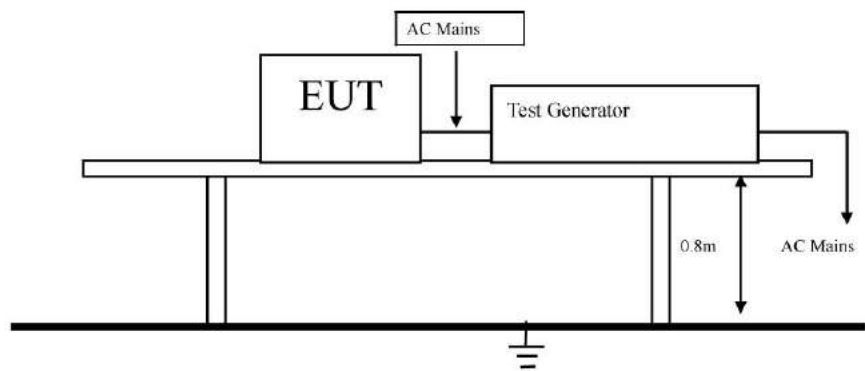


5.7.2 Test Method:

The test was performed in accordance with EN 61000-4-11:2004

Performance Criterion Require: C&B (Please see following table)

Block diagram of Test setup



5.7.3 Susceptibility performance Criteria and Severity Level

Susceptibility performance Criteria

Criterion	Description
A	No change in operational mode or degradation of performance outside of specification and no change in stored parameters.
B	Degradation of performance allowed during the test the EUT returning to intended operation after the test.
C	Loss of function allowed during the test, provided that function is self recoverable or can be recovered by operation of controls.

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Severity Level

Voltage Dip	Test Level %Ut	Reduction	Duration (Periods)	Performance Criteria
	<5	>95	0.5	B
	70	30	25	C
Voltage Interceptions	Test Level %Ut	Reduction	Duration (Periods)	Performance Criteria
	<5	>95	250	C

5.7.4 Test Result:

EUT Operating Environment

Temperature: 25°C Humidity: 75%RH Atmospheric Pressure: 101 KPa

Please refer to the following page

Voltage Dip:

Test Level % Ut	Reduction	Duration (periods)	Phase Angle	Meet Criterion	Result
0	100	0.5	0° - 360°	A	Pass
70	30	25	0° - 360°	A	Pass

Voltage Interceptions:

Test Level % Ut	Reduction	Duration (periods)	Phase Angle	Meet Criterion	Result
0	100	250	0° - 360°	B	Pass

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6.0 Product Labelling

6.1 CE Mark label specification

Text of the mark is black or white in color and is left justified. Labels are printed in indelible ink on permanent adhesive backing and shall be affixed at a conspicuous location on the EUT or silk-screened onto the EUT.



6.2 Mark Location: Rear enclosure

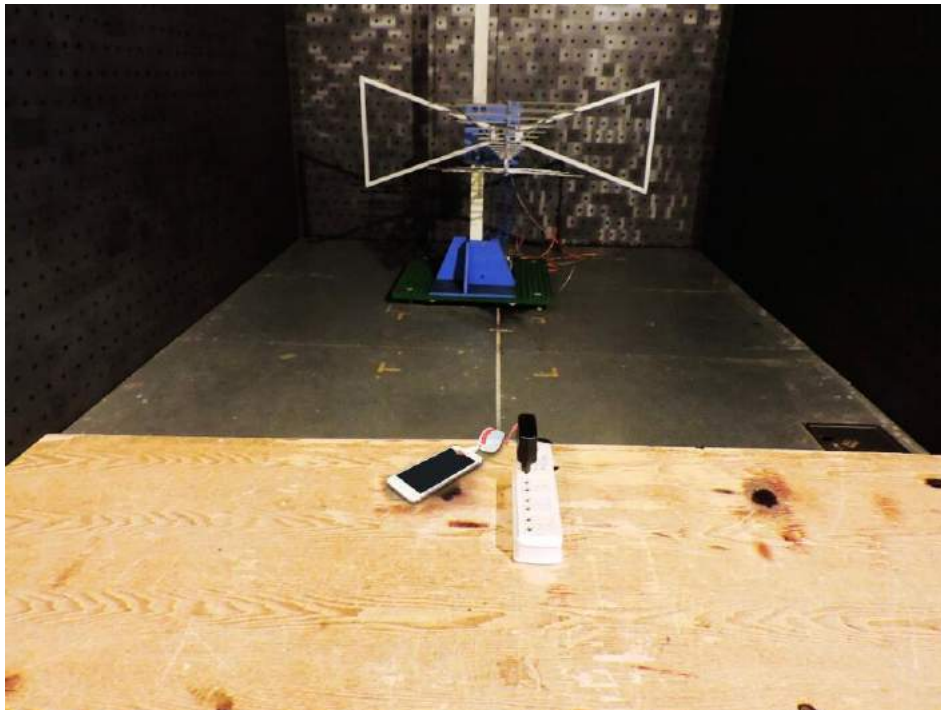
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7.0 Photo of testing



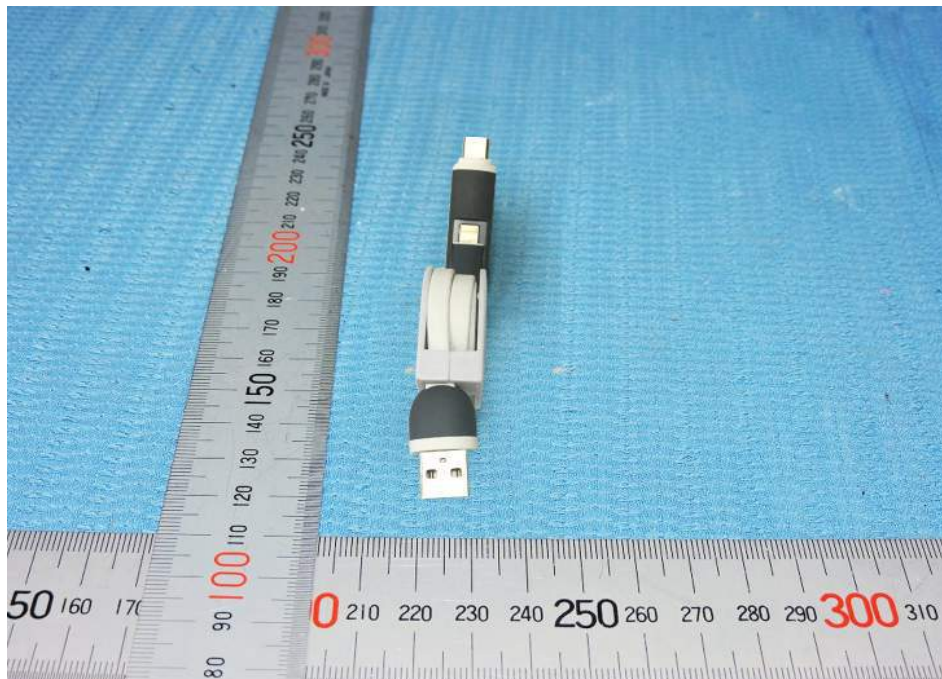
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Photo for the EUT



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Photo for the EUT



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Photo for the EUT



-End of the report-

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